

APPROVAL SHEET

WLFM_C Multi-Layer Power Inductor





*Contents in this sheet are subject to change without prior notice.

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ASC_WLFM_C Series



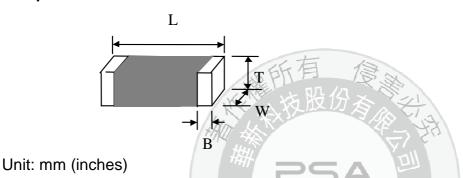
Features

- 1. General purpose chip ferrite power inductor for high integration electronics device.
- 2. Ceramic structure provides high reliability high productivity.
- 3. Low DC resistance with high current.
- 4. RoHS compliance.

Applications

- 1. DC line filter, DC/DC inductor.
- 2. Suitable for DVD,DSC,PND,PC,NB,Power Line.

Shape and Dimension



		200	TVE EVETEM ALLTAN		
	WLFM		W	т	В
	Series	L	VV	1	(Min/Max)
	WLFM201209	2.00±0.20	1.25±0.20	0.90±0.10	0.50±0.30
	WLFM201609	2.00±0.20	1.60±0.20	0.90±0.10	0.50±0.30
	WLFM252009	2.50±0.20	2.00±0.20	0.90±0.10	0.50±0.30

Ordering Information

WL	FM	2012	09	M	R47	Р	С
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	С
WL: Inductor	Multilayer	2012:EIA 0805 2016:EIA 0806 2520:EIA 1008	09= 0.9mm	M: ± 20%	R47=0.47uH 2R2=2.2uH	P=7" Reeled (Embossed tape)	General

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Electrical Characteristics

WLFM C Series

Walsin Part Number	L(uH) Inductance	Tolerance	Test Freq (MHz)	RDC DC Resistance (Ω) Max.	Rated Current (mA)	SRF (MHz)
WLFM201209M1R0PC	1.00	±20%	1	0.10	1100	90
WLFM201209M2R2PC	2.20	±20%	1	0.17	900	70
WLFM201209M3R3PC	3.30	±20%	1	0.20	800	50
WLFM201209M4R7PC	4.70	±20%	1	0.23	800	40
Walsin Part Number	L(uH) Inductance	Tolerance	Test Freq (MHz)	RDC DC Resistance (Ω) Max.	Rated Current (mA)	SRF (MHz)
WLFM201609M2R2PC	2.20	±20%	1	0.12	1100	40
WLFM201609M4R7PC	4.70	±20%	1	0.16	900	20
Walsin Part Number	L(uH) Inductance	Tolerance	Test Freq (MHz)	RDC DC Resistance (Ω) Max.	Rated Current (mA)	SRF (MHz)
WLFM252009MR47PC	0.47	±20%	1	0.04	1800	100
WLFM252009M1R0PC	1.00	±20%	1	0.055	1600	60
WLFM252009M1R5PC	1.50	=AS ±20% VST	EM ALIA	0.07	1500	50
WLFM252009M2R2PC	2.20	±20%	1	0.08	1300	40
WLFM252009M3R3PC	3.30	±20%	1	0.10	1200	30
WLFM252009M4R7PC	4.70	±20%)gy1 ^{CO}	0.11	1100	25
WLFM252009M6R8PC	6.80	±20%) (OKPORALI	0.20	1100	25

^{*1 :} For special part number which is not shown in the above table, please refer to appendix.

Test Instrument:

- •HP4291B-RF Impedance / Material Analyzer
- •HP4338A/B Milliohm meter
- •Test Frequency: 1MHz / OSC Level: 100mV

^{*2 :} Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.

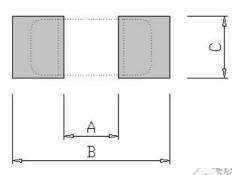


General Technical Data

Operating temperature range : - 40° C ~ +85 $^{\circ}$ C Storage Condition : Less than 40° C and 70% RH

Storage Time: 12 months Max. Soldering method: Reflow

Land Patterns for Reflow Soldering



Size(mm)	Α	B//	o C
2012	1.0 ~ 1.2	3.0 ~ 4.0	VE 0.8 = 1.1 IANK
2016	1.0 ~ 1.2	3.0 ~ 4.0	1.0 ~ 1.5
2520	1.2~1.5	3.5~4.0	1.5~2.0



Reliability and Test Conditions

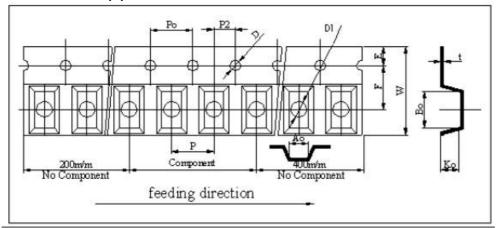
Test item	Test condition	Criteria	
		1.More than 95 % of terminal electrode should be covered with new solder	
	Solder temperature : 260 ± 5°C	2.No mechanical damage	
Resistance to Solder Heat	Flux : Rosin DIP time : 10 ± 1 sec	3.Inductance value should be within ± 20 % of the initial value	
		* Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.	
	Solder temperature : 235 ± 5°C	1. More than 95 % of terminal	
Solderability	Flux : Rosin	electrode should be covered with new solder	
	3. DIP time: 5 ± 1 sec	2. No mechanical damage	
Adhesive Test	Reflow temperature : 245°C It shall be Soldered on the substrate applying direction parallel to the substrate Apply force(F) : 5 N Test time : 10 sec	No mechanical damage Soldering the products on PCB after the pulling test force > 5 N	
Temperature Cycle	Temperature:-40 ~ 85°C For 30 minutes each Cycle: 100 cycles SYSTEM ALLIANCE Measurement:At ambient temperature 24 hours after test completion	1.No mechanical damage 2.Inductance should be within ±20% of the initial value * Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.	
High Temperature Resistance	Temperature: 85 ± 5°C Testing time: 1000 hrs Measurement: at ambient temperature 24 hours after test completion	1. No mechanical damage 2. Inductance should be within ±20% of the initial value * Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.	
	Temperature: 40°C ± 2°C	1.No mechanical damage	
	Humidity: 90-95 % RH	2.Inductance should be within ±20%	
Humidity	Testing time: 1000 hrs	of the initial value	
	Measurement:At ambient temperature 24 hours after test completion	* Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.	
	At ambient temperature & humidity	WLFM product surface temp ··	
Rated Current	Testing time:5 minutes (under full rated current)	below room temperature plus 40°C	

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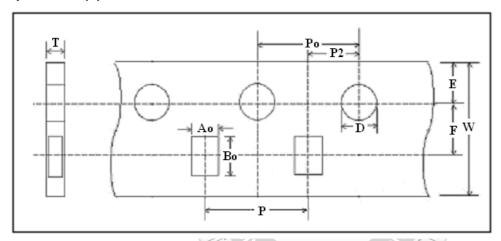
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Tape and Reel Specifications

Plastic Carries(E)



Paper Carrier(P)



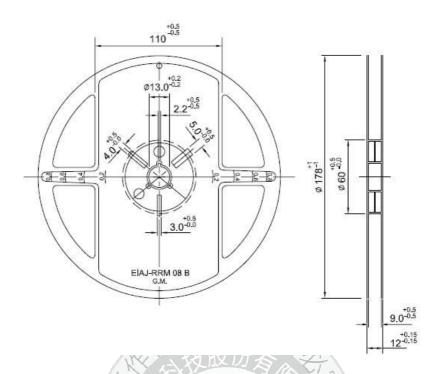
Taping Dimensions

		40////	
(mm)	2012	2016	2520
Symbol	E	E	JI CUNTON"
W	8.00 ± 0.10	8.00 ± 0.10	8.00 ± 0.10
Р	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10
Е	1.75 ± 0.10	1.75 ± 0.10	1.75 ± 0.10
F	3.50 ± 0.10	3.50 ± 0.10	3.50 ± 0.10
D	1.55 ± 0.05	1.55 ± 0.05	1.55 ± 0.05
D1	1.00 ± 0.05	1.00 ± 0.05	1.00 ± 0.05
Po	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10
10Po	40.0 ± 0.20	40.0 ± 0.20	40.0 ± 0.20
P2	2.00 ± 0.10	2.00 ± 0.10	2.00 ± 0.10
Ao	1.40 ± 0.10	1.80 ± 0.10	2.25 ± 0.10
Во	2.30 ± 0.10	2.20 ± 0.10	2.80 ± 0.10
Ko(T)	1.13 ± 0.10	1.15 ± 0.10	1.35 ± 0.10
t	0.22 ± 0.05	0.22 ± 0.05	0.22 ± 0.05

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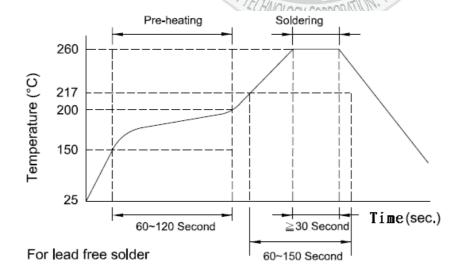
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Reel Dimensions



7" Reel Packaging Quantity				
PART SIZE 2012 (EIA SIZE) (0805)		2016 (0806) 2520 (1008)		
Qty.(pcs)	3,000	3,000	3,000	
вох	5 reels / inner box	5 reels / inner box	5 reels / inner box	

Recommended Soldering Conditions



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单击下面可查看定价,库存,交付和生命周期等信息

>>Walsin Technology(华新科技)